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Application/Control No.	Applicant(s)/Patent under Reexamination
10/721,289	CHANG ET AL.
Examiner	Art Unit
Thombood D. Tours	2425

	SEAR	CHED	
Class	Subclass	Date	Examiner
380	30, 37	4/12/2007	твт
726	. 3	4/12/2007	ТВТ
380	29, 264	4/15/2007	ТВТ
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
380	37	4/12/2007	ТВТ		
726	3	4/12/2007	ТВТ		
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SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
Inventor Name Search	4/12/2007	твт
Assignee Search	4/12/2007	твт
EAST Search	4/12/2007	ТВТ
TEXT Search	4/12/2007	ТВТ
NPL Search: Google	4/12/2007	ТВТ
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